DATA SHEET 74F00 Quad 2-input NAND gate **Product specification** 1990 Oct 04 IC15 Data Handbook

INTEGRATED CIRCUITS







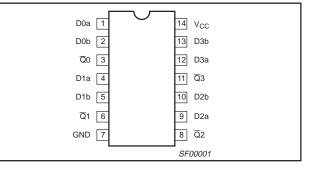
74F00

FEATURE

• Industrial temperature range available (-40°C to +85°C)

TYPE	TYPICAL PROPAGATION DELAY	TYPICAL SUPPLY CURRENT (TOTAL)
74F00	3.4ns	4.4mA

PIN CONFIGURATION



ORDERING INFORMATION

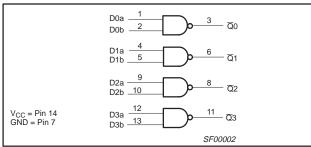
	C	ORDER CODE				
DESCRIPTION	COMMERCIAL RANGE V_{CC} = 5V ±10%, T_{amb} = 0°C to +70°C	INDUSTRIAL RANGE V_{CC} = 5V ±10%, T_{amb} = -40°C to +85°C	PKG DWG #			
14-pin plastic DIP	N74F00N	I74F00N	SOT27-1			
14-pin plastic SO	N74F00D	I74F00D	SOT108-1			

INPUT AND OUTPUT LOADING AND FAN OUT TABLE

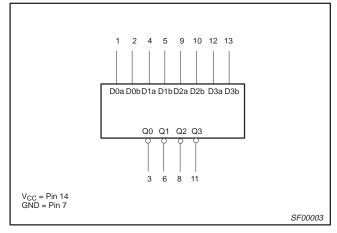
PINS	DESCRIPTION	74F (U.L.) HIGH/LOW	LOAD VALUE HIGH/LOW	
Dna, Dnb	Data inputs	1.0/1.0	20µA/0.6mA	
Qn	Data output	50/33	1.0mA/20mA	

NOTE: One (1.0) FAST unit load is defined as: 20µA in the high state and 0.6mA in the low state.

LOGIC DIAGRAM



LOGIC SYMBOL



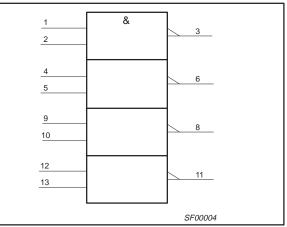
FUNCTION TABLE

INP	UTS	OUTPUT
Dna	Dnb	Qn
L	L	н
L	Н	Н
Н	L	Н
Н	н	L

NOTES:

H = High voltage level L = Low voltage level

IEC/IEEE SYMBOL



74F00

ABSOLUTE MAXIMUM RATINGS

(Operation beyond the limit set forth in this table may impair the useful life of the device. Unless otherwise noted these limits are over the operating free air temperature range.)

SYMBOL	PARAMETER		RATING	UNIT
V _{CC}	Supply voltage		-0.5 to +7.0	V
V _{IN}	Input voltage		-0.5 to +7.0	V
I _{IN}	Input current	-30 to +5	mA	
V _{OUT}	Voltage applied to output in high output state	–0.5 to V_{CC}	V	
I _{OUT}	Current applied to output in low output state		40	mA
T _{amb}	Operating free air temperature range	Commercial range	0 to +70	°C
		Industrial range	-40 to +85	°C
T _{stg}	Storage temperature range	-65 to +150	°C	

RECOMMENDED OPERATING CONDITIONS

SYMBOL	PARAMETER		UNIT			
			MIN	NOM	MAX	
V _{CC}	Supply voltage		4.5	5.0	5.5	V
V _{IH}	High-level input voltage	2.0			V	
V _{IL}	Low-level input voltage			0.8	V	
l _{lk}	Input clamp current				-18	mA
I _{OH}	High-level output current				-1	mA
I _{OL}	Low-level output current				20	mA
T _{amb}	Operating free air temperature range	Commercial range	0		+70	°C
		Industrial range	-40		+85	°C

DC ELECTRICAL CHARACTERISTICS

(Over recommended operating free-air temperature range unless otherwise noted.)

SYMBOL	BOL PARAMETER		TEST CONDITIO	TEST CONDITIONS ¹		LIMITS			
							MAX	1	
V _{OH}	High-level output voltage		$V_{CC} = MIN, V_{IL} = MAX$	±10%V _{CC}	2.5			V	
			$V_{IH} = MIN, I_{OH} = MAX$	±5%V _{CC}	2.7	3.4		V	
V _{OL}	Low-level output voltage		$V_{CC} = MIN, V_{IL} = MAX$	±10%V _{CC}		0.30	0.50	V	
			$V_{IH} = MIN, I_{OI} = MAX$	±5%V _{CC}		0.30	0.50	V	
V _{IK}	Input clamp voltage		$V_{CC} = MIN, I_I = I_{IK}$			-0.73	-1.2	V	
l	Input current at maximum input voltage		$V_{CC} = MAX, V_I = 7.0V$				100	μA	
I _{IH}	High-level input current		$V_{CC} = MAX, V_I = 2.7V$				20	μΑ	
IIL	Low-level input current		$V_{CC} = MAX, V_I = 0.5V$				-0.6	mA	
I _{OS}	Short-circuit output currer	nt ³	V _{CC} = MAX		-60		-150	mA	
I _{CC}	Supply current (total)	I _{CCH}	V _{CC} = MAX	$V_{IN} = GND$		1.9	2.8	mA	
		I _{CCL}	V _{CC} = MAX	V _{IN} = 4.5V		6.8	10.2	mA	

NOTES:

1. For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions for the applicable type. 2. All typical values are at $V_{CC} = 5V$, $T_{amb} = 25^{\circ}C$.

Not more than one output should be shorted at a time. For testing I_{OS}, the use of high-speed test apparatus and/or sample-and-hold techniques are preferable in order to minimize internal heating and more accurately reflect operational values. Otherwise, prolonged shorting 3. of a high output may raise the chip temperature well above normal and thereby cause invalid readings in other parameter tests. In any sequence of parameter tests, IOS tests should be performed last.

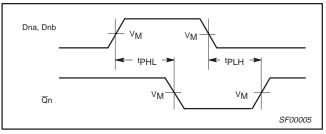
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AC ELECTRICAL CHARACTERISTICS

			LIMITS							
SYMBOL	PARAMETER	TEST CONDITION	$T_{amb} = +2$		V_{CC} = +5.0V T _{amb} = +25°C C _L = 50pF, R _L = 500Ω		$\label{eq:V_{CC}} \begin{split} V_{CC} &= +5.0V \pm 10\% \\ T_{amb} &= 0^{\circ}\text{C to} + 70^{\circ}\text{C} \\ C_L &= 50\text{pF}, \ R_L = 500\Omega \end{split}$		$\label{eq:V_CC} \begin{array}{l} \textbf{V}_{CC} = \textbf{+5.0V} \pm \textbf{10\%} \\ \textbf{T}_{amb} = -40^{\circ} \textbf{C} \text{ to } \textbf{+85^{\circ} C} \\ \textbf{C}_{L} = \textbf{50pF}, \textbf{R}_{L} = \textbf{500} \Omega \end{array}$	
			MIN	TYP	MAX	MIN	MAX	MIN	MAX	
t _{PLH} t _{PHL}	Propagation delay Dna, Dnb to Qn	Waveform 1	2.4 2.0	3.7 3.2	5.0 4.3	2.4 2.0	6.0 5.3	2.0 1.5	6.5 6.0	ns

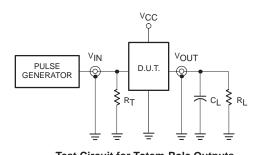
AC WAVEFORMS

For all waveforms, $V_M = 1.5V$.



Waveform 1. Propagation delay for inverting outputs

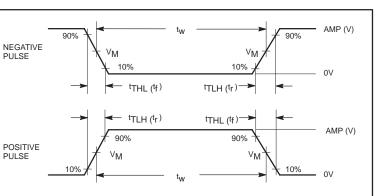
TEST CIRCUIT AND WAVEFORM



Test Circuit for Totem-Pole Outputs

DEFINITIONS:

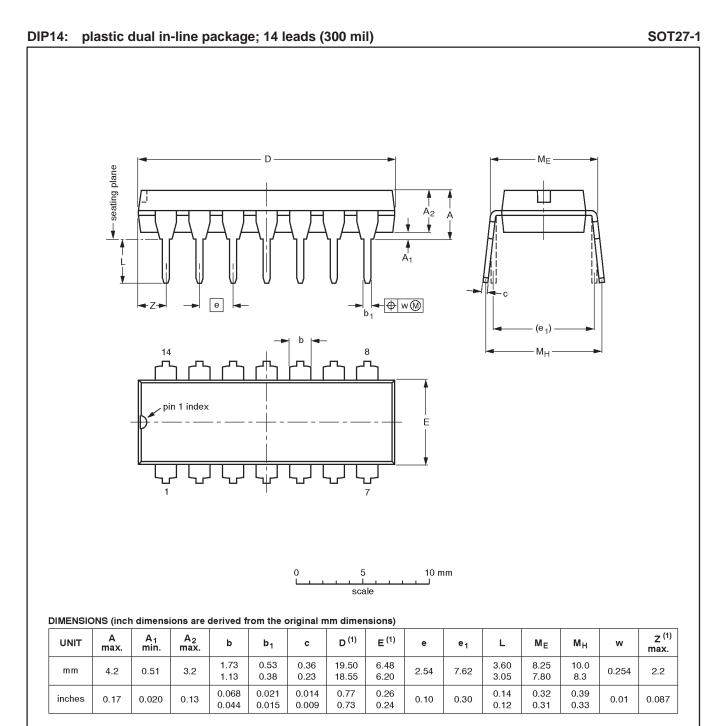
- R_L = Load resistor;
- see AC ELECTRICAL CHARACTERISTICS for value. C_L = Load capacitance includes jig and probe capacitance; see AC ELECTRICAL CHARACTERISTICS for value.
- R_T = Termination resistance should be equal to Z_{OUT} of pulse generators.



Input Pulse Definition

family	INPUT PULSE REQUIREMENTS						
family	amplitude	VM	rep. rate	tw	t _{TLH}	t _{THL}	
74F	3.0V	1.5V	1MHz	500ns	2.5ns	2.5ns	

SF00006



Note

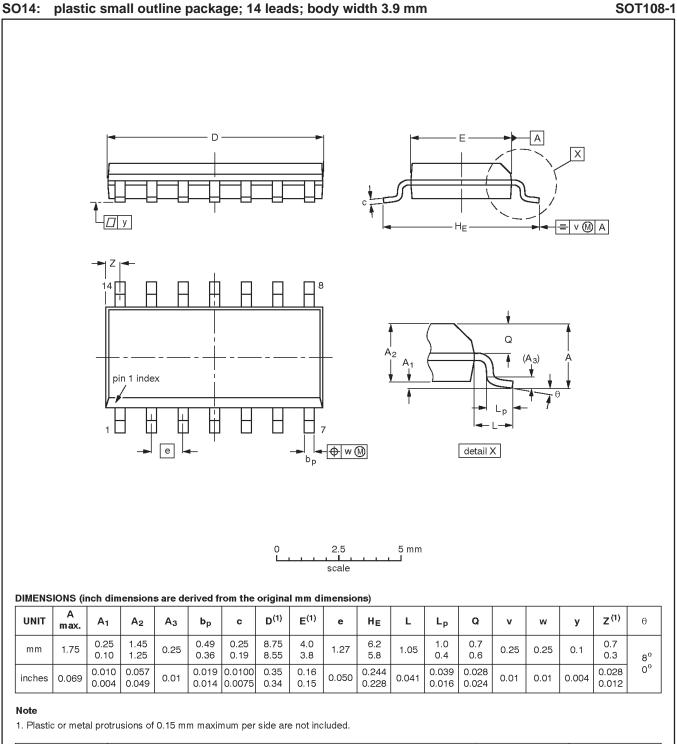
1. Plastic or metal protrusions of 0.25 mm maximum per side are not included.

OUTLINE		REFER	EUROPEAN ISSUE DATE			
VERSION	IEC	JEDEC	EIAJ		PROJECTION	ISSUE DATE
SOT27-1	050G04	MO-001AA				-92-11-17 95-03-11

Product specification

74F00

74F00



OUTLINE		REFERENCES EUROPEAN				ISSUE DATE	
VERSION	IEC	JEDEC	EIAJ		PROJECTION	ISSUE DATE	
SOT108-1	076E06S	MS-012AB				-95-01-23 97-05-22	

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Product specification

74F00

NOTES

74F00

Data sheet status

Data sheet status	Product status	Definition ^[1]
Objective specification	Development	This data sheet contains the design target or goal specifications for product development. Specification may change in any manner without notice.
Preliminary specification	Qualification	This data sheet contains preliminary data, and supplementary data will be published at a later date. Philips Semiconductors reserves the right to make chages at any time without notice in order to improve design and supply the best possible product.
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[1] Please consult the most recently issued datasheet before initiating or completing a design.

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